



N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON)} max	I _D max T _A = +25°C		
30V	14mΩ @ V _{GS} = 10V	8.6A		
30 V	20mΩ @ V _{GS} = 4.5V	7.1A		

Description

This MOSFET has been designed to minimize the on-state resistance $(R_{DS(ON)})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Backlighting
- Power Management Functions
- DC-DC Converters

Features

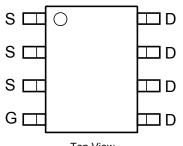
- Low On-Resistance
- Low Input Capacitance
- · Fast Switching Speed
- Low Input/Output Leakage
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

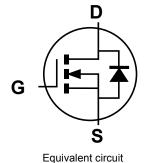
- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Terminals: Finish Matte Tin annealed over Copper lead frame.
 Solderable per MIL-STD-202, Method 208 ³
- Weight: 0.072g (approximate)







Top View Internal Schematic



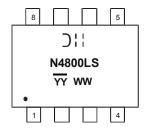
Ordering Information (Note 4)

Part Number	Case	Packaging
DMN4800LSS-13	SO-8	2500/Tape & Reel

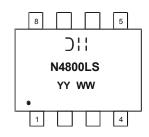
Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



Chengdu A/T Site



Shanghai A/T Site

⊃¦¦ = Manufacturer's Marking
 N4800LS = Product Type Marking Code
 YYWW = Date Code Marking
 YY or YY = Year (ex: 13 = 2013)
 WW = Week (01 - 53)

YY = Date Code Marking for SAT (Shanghai Assembly/ Test site)
YY = Date Code Marking for CAT (Chengdu Assembly/ Test site)



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Drain-Source Voltage	V_{DSS}	30	V		
Gate-Source Voltage	V _{GSS}	±25	V		
Continuous Preis Correct (Note C) V = 40V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	8.6 6.3	Α
Continuous Drain Current (Note 6) V _{GS} = 10V	t<10s	T _A = +25°C T _A = +70°C	I _D	11.8 9.0	Α
Maximum Body Diode Forward Current (Note 6)	Is	2.4	Α		
Pulsed Drain Current (Note 7)			I _{DM}	50	Α

Thermal Characteristics

Characteristic	Symbol	Value	Units		
Total Dawar Dissipation (Note 5)	T _A = +25°C		1.46	W	
Total Power Dissipation (Note 5)	$T_A = +70^{\circ}C$	P _D	0.9	T vv	
Thermal Resistance, Junction to Ambient (Note 5)	Steady state	В	86	°C/W	
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	$R_{\theta JA}$	46	C/W	
Total Dawar Dissipation (Note 6)	$T_A = +25^{\circ}C$	D-	1.7	W	
Total Power Dissipation (Note 6)	$T_A = +70^{\circ}C$	P _D	1.0		
Thermal Resistance, Junction to Ambient (Note 6)	Steady state		75		
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	R _θ JA	40	°C/W	
Thermal Resistance, Junction to Case (Note 6)		$R_{ heta JC}$	15		
Operating and Storage Temperature Range	T _{J,} T _{STG}	-55 to +150	°C		

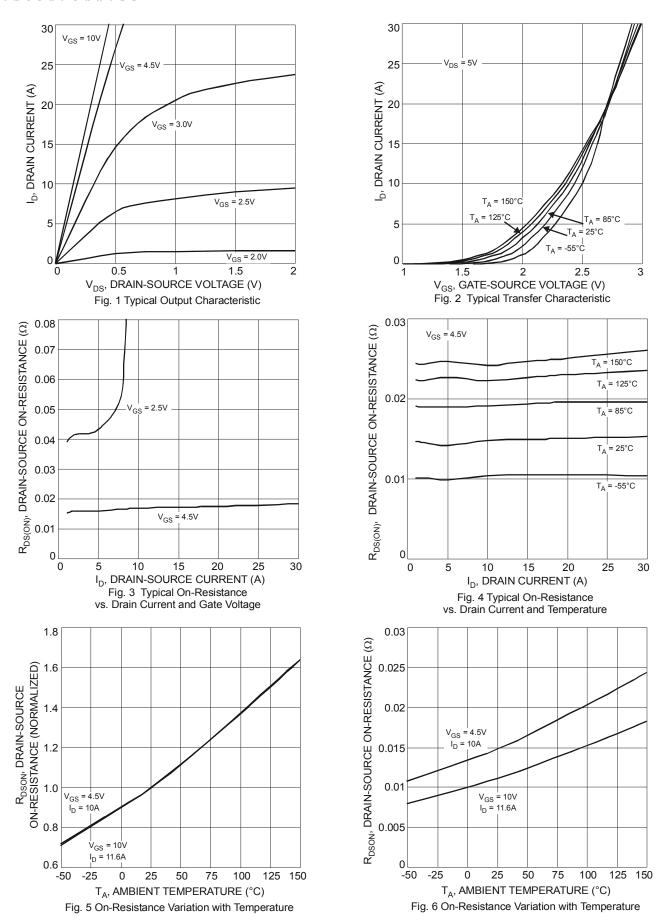
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	t Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV _{DSS}	30		_	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	_		1	μΑ	$V_{DS} = 30V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	V _{GS(th)}	0.8	1.2	1.6	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$	
Static Drain-Source On-Resistance	D		11	14	mΩ	$V_{GS} = 10V, I_D = 9A$	
Static Dialit-Source Off-Resistance	R _{DS (ON)}		14	20	11122	$V_{GS} = 4.5V, I_D = 7A$	
Forward Transconductance	9 _{fs}	_	8		S	$V_{DS} = 10V, I_D = 9A$	
Diode Forward Voltage (Note 8)	V_{SD}		0.72	0.94	V	$V_{GS} = 0V, I_{S} = 1A$	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	C _{iss}		798	_	pF	1, 40,4,14, 0,4	
Output Capacitance	Coss		128		pF V _{DS} = 10V, V _{GS} = 0V f = 1.0MHz		
Reverse Transfer Capacitance	C _{rss}	_	122	_	pF	1 - 1.000112	
Gate Resistance	R_G	_	1.37		Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$	
Total Gate Charge	Qg	_	8.7	_			
Gate-Source Charge	Q_{gs}	_	1.7		nC	$V_{GS} = 5V, V_{DS} = 15V, I_D = 9A$	
Gate-Drain Charge	Q_{gd}	_	2.4	_			
Turn-On Delay Time	t _{d(on)}	_	5.03	_			
Rise Time	t _r	_	4.50	_	$V_{DD} = 15V, V_{GEN} = 10V,$		
Turn-Off Delay Time	t _{d(off)}	_	26.33	_	ns	$R_L = 15\Omega$, $R_G = 6.0\Omega$, $I_D = 1A$	
Fall Time	t _f	_	8.55	_			

Notes:

- Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
 Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper pad layout
 Repetitive rating, pulse width limited by junction temperature.
 Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing.







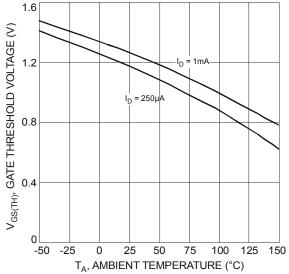
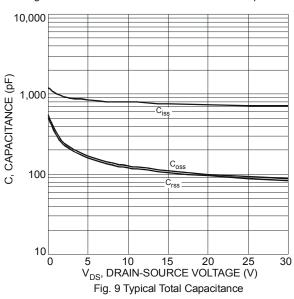


Fig. 7 Gate Threshold Variation vs. Ambient Temperature



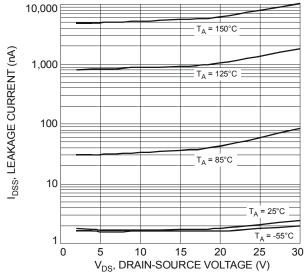
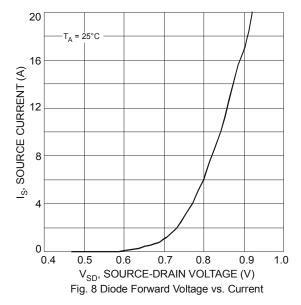
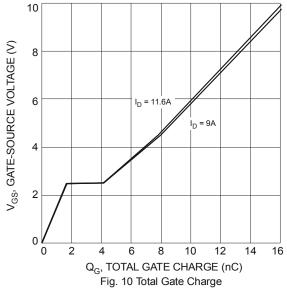
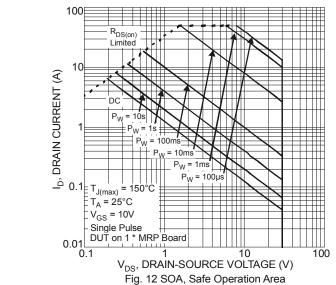


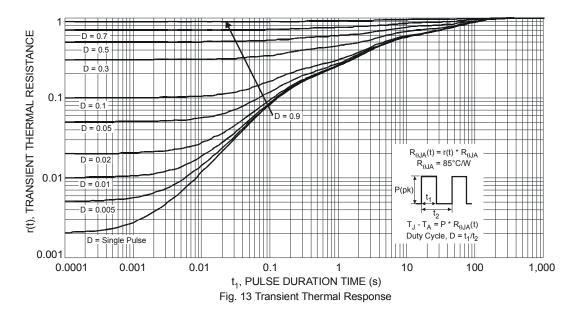
Fig. 11 Typical Leakage Current vs. Drain-Source Voltage



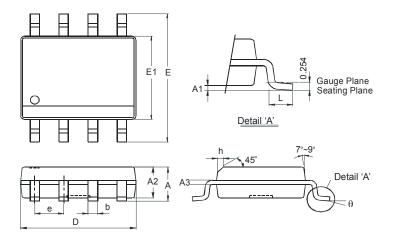






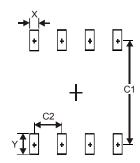


Package Outline Dimensions



SO-8					
Dim	Min	Max			
Α	1	1.75			
A1	0.10	0.20			
A2	1.30	1.50			
А3	0.15	0.25			
þ	0.3	0.5			
D	4.85	4.95			
Е	5.90	6.10			
E1	3.85	3.95			
Ф	1.27 Typ				
h	-	0.35			
٦	0.62	0.82			
θ	0°	8°			
All Dimensions in mm					

Suggested Pad Layout



Dimensions	Value (in mm)			
X	0.60			
Υ	1.55			
C1	5.4			
C2	1.27			



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